

TC74VHC373F, TC74VHC373FW, TC74VHC373FT

Octal D-Type Latch with 3-State Output

The TC74VHC373 is an advanced high speed CMOS OCTAL LATCH with 3-STATE OUTPUT fabricated with silicon gate C²MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

This 8-bit D-type latch is controlled by a latch enable input (LE) and a output enable input ($\overline{OE}$).

When the $\overline{OE}$ input is high, the eight outputs are in a high impedance state.

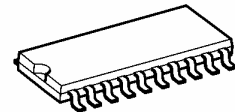
An input protection circuit ensures that 0 to 5.5 V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5 V to 3 V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

Features

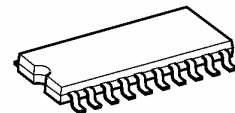
- High speed: $t_{pd} = 5.0 \text{ ns}$ (typ.) at $V_{CC} = 5 \text{ V}$
- Low power dissipation: $I_{CC} = 4 \mu\text{A}$ (max) at $T_a = 25^\circ\text{C}$
- High noise immunity: $V_{NIH} = V_{NIL} = 28\% V_{CC}$ (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays: $t_{pLH} \approx t_{pHL}$
- Wide operating voltage range: $V_{CC}(\text{opr}) = 2 \text{ to } 5.5 \text{ V}$
- Low noise: $V_{OLP} = 0.9 \text{ V}$ (max)
- Pin and function compatible with 74ALS373

Note: xxxFW (JEDEC SOP) is not available in Japan.

TC74VHC373F

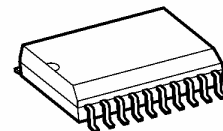


SOP20-P-300-1.27A



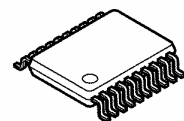
SOP20-P-300-1.27

TC74VHC373FW



SOL20-P-300-1.27

TC74VHC373FT

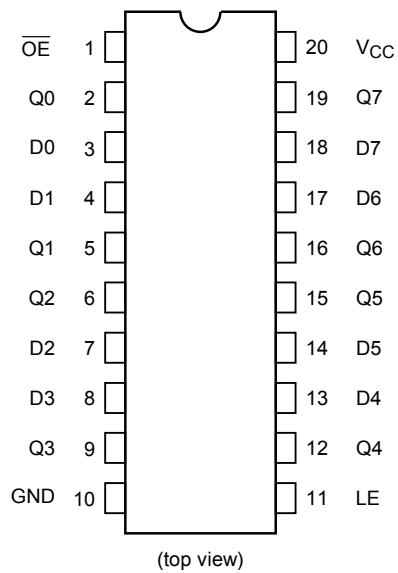


TSSOP20-P-0044-0.65A

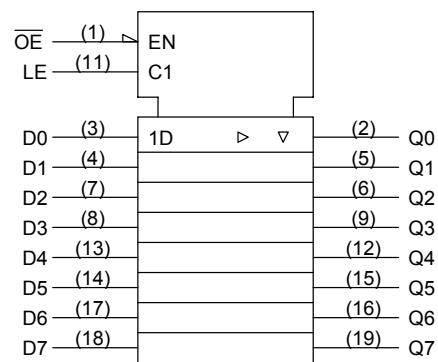
Weight

SOP20-P-300-1.27A	: 0.22 g (typ.)
SOP20-P-300-1.27	: 0.22 g (typ.)
SOL20-P-300-1.27	: 0.46 g (typ.)
TSSOP20-P-0044-0.65A	: 0.08 g (typ.)

Pin Assignment



IEC Logic Symbol



Truth Table

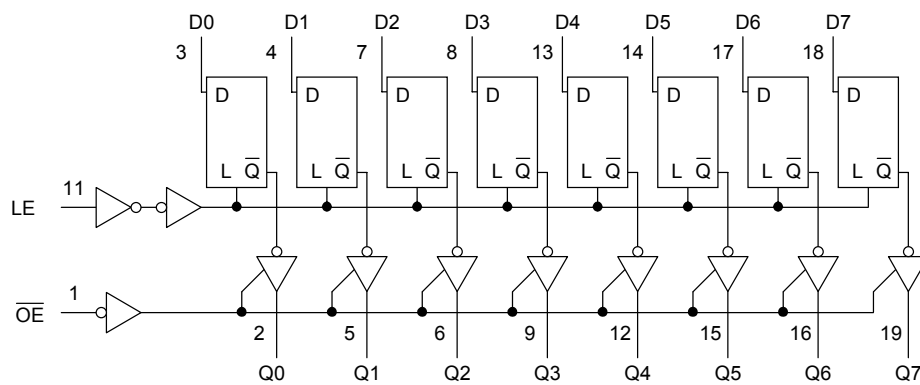
Inputs			Output
$\overline{OE}$	LE	D	
H	X	X	Z
L	L	X	Q_n
L	H	L	L
L	H	H	H

X: Don't care

Z: High impedance

Q_n : Q outputs are latched at the time when the LE input is taken to a low logic level.

System Diagram



Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage range	V_{CC}	-0.5 to 7.0	V
DC input voltage	V_{IN}	-0.5 to 7.0	V
DC output voltage	V_{OUT}	-0.5 to $V_{CC} + 0.5$	V
Input diode current	I_{IK}	-20	mA
Output diode current	I_{OK}	± 20	mA
DC output current	I_{OUT}	± 25	mA
DC V_{CC} /ground current	I_{CC}	± 75	mA
Power dissipation	P_D	180	mW
Storage temperature	T_{stg}	-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Recommended Operating Conditions (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage	V_{CC}	2.0 to 5.5	V
Input voltage	V_{IN}	0 to 5.5	V
Output voltage	V_{OUT}	0 to V_{CC}	V
Operating temperature	T_{opr}	-40 to 85	°C
Input rise and fall time	dt/dv	0 to 100 ($V_{CC} = 3.3 \pm 0.3$ V) 0 to 20 ($V_{CC} = 5 \pm 0.5$ V)	ns/V

Note: The recommended operating conditions are required to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

Electrical Characteristics

DC Characteristics

Characteristics	Symbol	Test Condition		Ta = 25°C				Ta = -40 to 85°C		Unit
				V _{CC} (V)	Min	Typ.	Max	Min	Max	
High-level input voltage	V _{IH}	—		2.0 3.0 to 5.5	1.50 V _{CC} × 0.7	— —	— —	1.50 V _{CC} × 0.7	— —	V
Low-level input voltage	V _{IL}	—		2.0 3.0 to 0.5	— —	— —	0.50 V _{CC} × 0.3	— —	0.50 V _{CC} × 0.3	V
High-level output voltage	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -50 μA	2.0	1.9	2.0	—	1.9	—	V
				3.0	2.9	3.0	—	2.9	—	
				4.5	4.4	4.5	—	4.4	—	
			I _{OH} = -4 mA I _{OH} = -8 mA	3.0	2.58	—	—	2.48	—	
				4.5	3.94	—	—	3.80	—	
Low-level output voltage	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 50 μA	2.0	—	0.0	0.1	—	0.1	V
				3.0	—	0.0	0.1	—	0.1	
				4.5	—	0.0	0.1	—	0.1	
			I _{OL} = 4 mA I _{OL} = 8 mA	3.0	—	—	0.36	—	0.44	
				4.5	—	—	0.36	—	0.44	
3-state output off-state current	I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = V _{CC} or GND		5.5	—	—	±0.25	—	±2.50	μA
Input leakage current	I _{IN}	V _{IN} = 5.5 V or GND		0 to 5.5	—	—	±0.1	—	±1.0	μA
Quiescent supply current	I _{CC}	V _{IN} = V _{CC} or GND		5.5	—	—	4.0	—	40.0	μA

Timing Requirements (input: t_r = t_f = 3 ns)

Characteristics	Symbol	Test Condition		Ta = 25°C		Ta = -40 to 85°C	Unit
				V _{CC} (V)	Typ.	Limit	
Minimum pulse width (LE)	t _w (H)	—		3.3 ± 0.3 5.0 ± 0.5	— —	5.0 5.0	ns
Minimum set-up time	t _s	—		3.3 ± 0.3 5.0 ± 0.5	— —	4.0 4.0	ns
Minimum hold time	t _h	—		3.3 ± 0.3 5.0 ± 0.5	— —	1.0 1.0	ns

AC Electrical Characteristics (input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol	Test Condition			Ta = 25°C			Ta = -40 to 85°C		Unit
			V _{CC} (V)	C _L (pF)	Min	Typ.	Max	Min	Max	
Propagation delay time (LE-Q)	t _{pLH} t _{pHL}	—	3.3 ± 0.3	15	—	7.0	11.0	1.0	13.0	ns
				50	—	9.5	14.5	1.0	16.5	
			5.0 ± 0.5	15	—	4.9	7.2	1.0	8.5	
				50	—	6.4	9.2	1.0	10.5	
Propagation delay time (D-Q)	t _{pLH} t _{pHL}	—	3.3 ± 0.3	15	—	7.3	11.4	1.0	13.5	ns
				50	—	9.8	14.9	1.0	17.0	
			5.0 ± 0.5	15	—	5.0	7.2	1.0	8.5	
				50	—	6.5	9.2	1.0	10.5	
3-state output enable time	t _{pZL} t _{pZH}	R _L = 1 kΩ	3.3 ± 0.3	15	—	7.3	11.4	1.0	13.5	ns
				50	—	9.8	14.9	1.0	17.0	
			5.0 ± 0.5	15	—	5.5	8.1	1.0	9.5	
				50	—	7.0	10.1	1.0	11.5	
3-state output disable time	t _{pLZ} t _{pHZ}	R _L = 1 kΩ	3.3 ± 0.3	50	—	9.5	13.2	1.0	15.0	ns
			5.0 ± 0.5	50	—	6.5	9.2	1.0	10.5	
Output to output skew	t _{osLH} t _{osHL}	(Note 1)	3.3 ± 0.3	50	—	—	1.5	—	1.5	ns
			5.0 ± 0.5	50	—	—	1.0	—	1.0	
Input capacitance	C _{IN}	—			—	4	10	—	10	pF
Output capacitance	C _{OUT}	—			—	6	—	—	—	pF
Power dissipation capacitance	C _{PD}	(Note 2)			—	27	—	—	—	pF

Note 1: Parameter guaranteed by design.

$$t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|$$

Note 2: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC(opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 \text{ (per latch)}$$

And the total C_{PD} when n pcs. of Latch operate can be gained by the following equation:

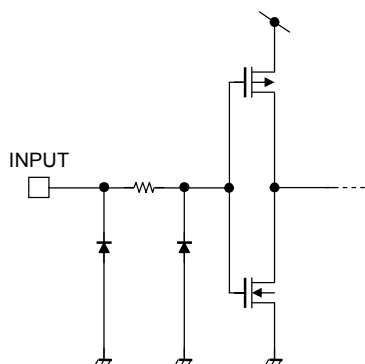
$$C_{PD}(\text{total}) = 14 + 13 \cdot n$$

Noise Characteristics (input: $t_r = t_f = 3 \text{ ns}$) (Note)

Characteristics	Symbol	Test Condition	$V_{CC} \text{ (V)}$	$T_a = 25^\circ\text{C}$		Unit
				Typ.	Max	
Quiet output maximum dynamic V_{OL}	V_{OLP}	$C_L = 50 \text{ pF}$	5.0	0.5 (0.6)	0.8 (0.9)	V
Quiet output minimum dynamic V_{OL}	V_{OLV}	$C_L = 50 \text{ pF}$	5.0	-0.5 (-0.6)	-0.8 (-0.9)	V
Minimum high level dynamic input voltage	V_{IHD}	$C_L = 50 \text{ pF}$	5.0	—	3.5	V
Maximum low level dynamic input voltage	V_{ILD}	$C_L = 50 \text{ pF}$	5.0	—	1.5	V

Note: The value in () only applies to JEDEC SOP (FW) devices.

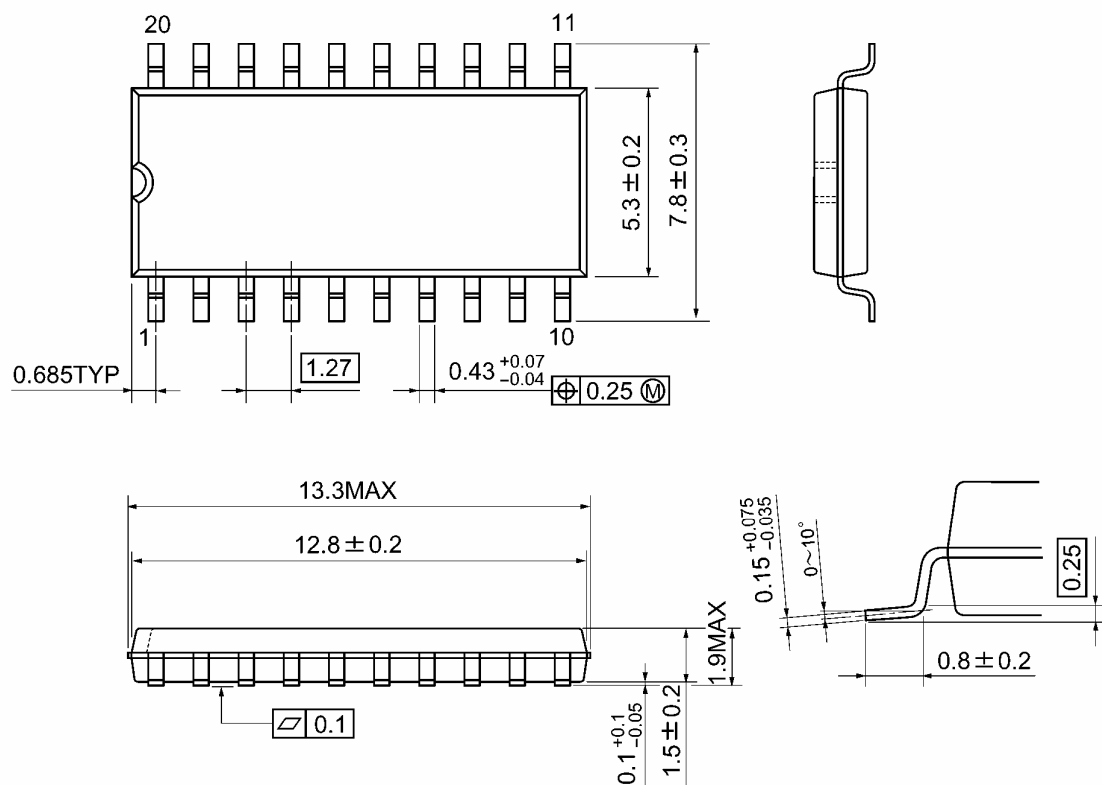
Input Equivalent Circuit



Package Dimensions

SOP20-P-300-1.27A

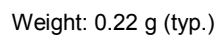
Unit: mm



Weight: 0.22 g (typ.)

SOP20-P-300-1.27

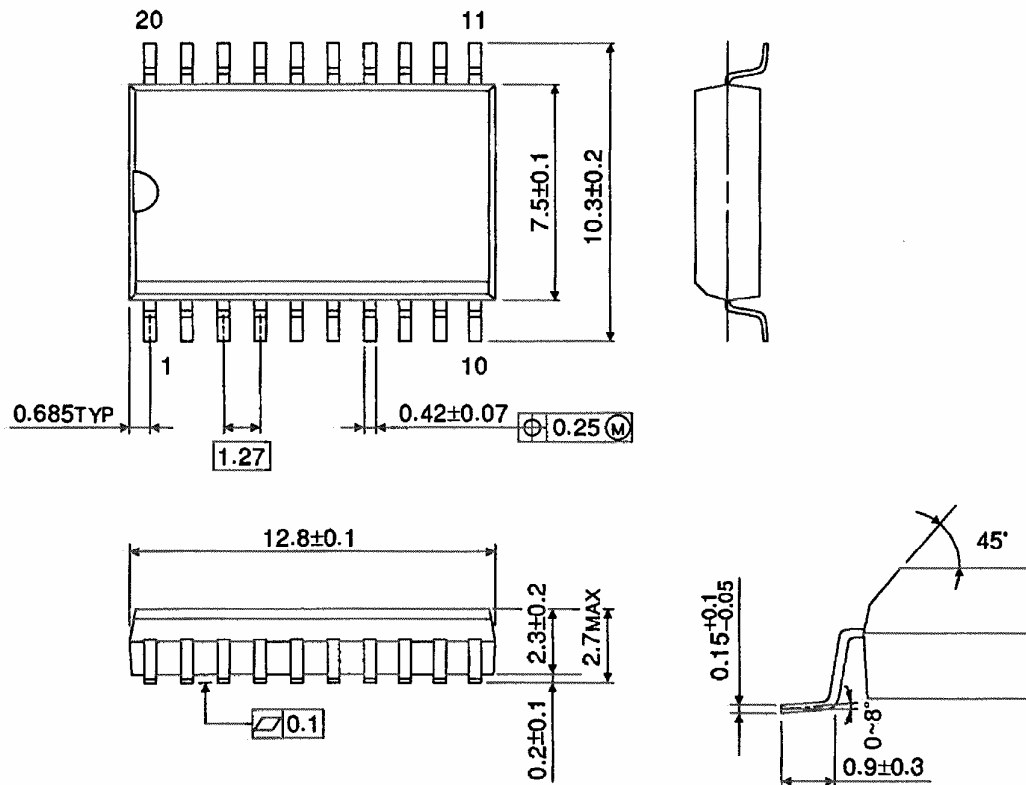
Unit : mm



Package Dimensions (Note)

SOL20-P-300-1.27

Unit : mm



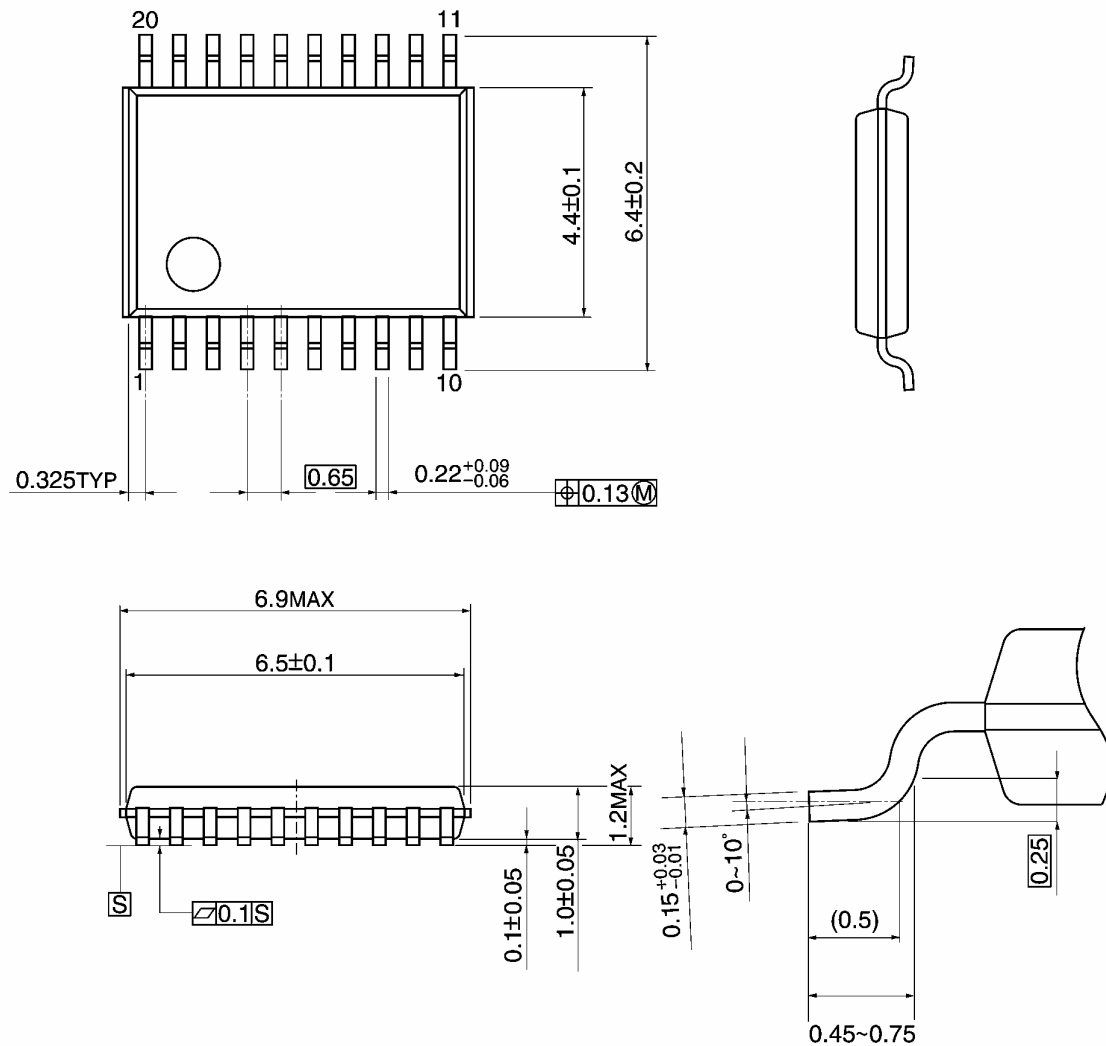
Note: This package is not available in Japan.

Weight: 0.46 g (typ.)

Package Dimensions

TSSOP20-P-0044-0.65A

Unit: mm



Weight: 0.08 g (typ.)

Note: Lead (Pb)-Free Packages

SOP20-P-300-1.27A TSSOP20-P-0044-0.65A

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